

SHEET 1 OF 1

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
251807US0CONTSERIAL NO.
10/821,899

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Hachiro HIRANO, et al.FILING DATE
April 12, 2004

GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>mp</i>	AA	6,685,901	02/03/2004	H. HIRANO, et al.	423	240S	
	AB						
	AC						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>mp</i>	AO	2002-143640	05/21/2002	JAPAN		X
	AP	10-277363	10/20/1998	JAPAN		X
	AQ	1 063 001	12/27/2000	EUROPE		
	AR	4-187211	07/03/1992	JAPAN		X
	AS	62-121621	06/02/1987	JAPAN		X
	AT	61-61619	03/29/1986	JAPAN (with English Abstract)		X
<i>mp</i>	AU	62-42727	02/24/1987	JAPAN (with English Abstract)		X
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

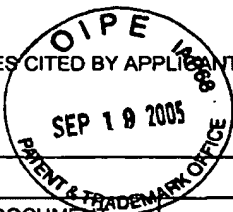
	AW	
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	AZ	

☐ Additional References sheet(s) attachedExaminer *Ngon. Ngon Ngonen*Date Considered *01/05/07*

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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1724

U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>yn</i>	AO	1372488 A	05/24/2001	China (Submitting Corr. WO 01/89666 A1 only)		
<i>yn</i>	AP	WO 01/89666 A1	11/29/2001	WIPO		
	AQ					
	AR					
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	<input type="checkbox"/> Additional References sheet(s) attached

Examiner

Ngoz. yen Nguyen

Date Considered

01/05/07

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U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>Ym</i>	AA	6,146,606	11/14/2000	Hitoshi ATOBE, et al.	423	239.1	
	AB						
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FOREIGN PATENT DOCUMENTS

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	AO					
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	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

<i>Ym</i>	AW	Patent Abstracts of Japan, JP 04-305245, October 28, 1992
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

Ngor-Yen Nguyen

Date Considered

1/05/08

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